
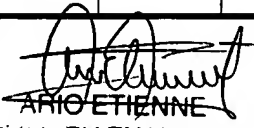


<b>Issue Classification</b> 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/056,091		SHIMADA ET AL.	
	Examiner		Art Unit	
	Sargon N. Nano		2157	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
709		229			709	227	228			
INTERNATIONAL CLASSIFICATION										
G	0	6	F	15/16						
				/						
				/						
				/						
				/						
Sargon Nano (Assistant Examiner) (Date)					 <b>ARIO ETIENNE</b> PRIMARY EXAMINER (Primary Examiner)			Total Claims Allowed: 15		
(Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1		O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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